

Notice of References Cited			Application/Control No. 10/029,779	Applicant(s)/Patent Under Reexamination HEIDEMANN ET AL.	
			Examiner L Blaine Lankford	Art Unit 1651	Page 1 of 1

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	M	US-			

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NON-PATENT DOCUMENTS

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X	U	Whitaker et al., Journal of the American Chemical Society, pages 28-43, 1998.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.